



POWER FIELD EFFECT TRANSISTOR

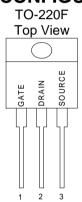
GENERAL DESCRIPTION

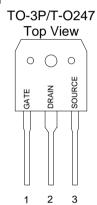
This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

FEATURES

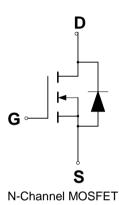
- ◆ Robust High Voltage Termination
- ◆ Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- ◆ Diode is Characterized for Use in Bridge Circuits
- ◆ I_{DSS} and V_{DS}(on) Specified at Elevated Temperature
- Isolated Mounting Hole Reduces Mounting Hardware

PIN CONFIGURATION





SYMBOL



ABSOLUTE MAXIMUM RATINGS

Rating		Value	Unit
Drain to Current — Continuous		15	Α
- Pulsed		45	
Gate-to-Source Voltage — Continue		±30	V
Total Power Dissipation – TO220FP	P _D	57	W
– TO3P		255	W/°C
– TO247		235	
Derate above 25℃ - TO220FP		0.38	
– TO3P		2.3	
– TO247		1.95	
Operating and Storage Temperature Range		-55 to 150	$^{\circ}\!\mathbb{C}$
Single Pulse Drain-to-Source Avalanche Energy − T _J = 25°C		845	
$(V_{DD} = 100V, V_{GS} = 10V, I_L = 13A, L = 10mH, R_G = 25)$			mJ
Thermal Resistance — Junction to Case -TO220FP		3.12	°C/W
 Junction to Case -TO3P 		0.45	
 Junction to Case -TO247 		0.59	
 Junction to Ambient -TO220FP 	JA	62.5	
 Junction to Ambient -TO3P, TO247 		40	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds		260	$^{\circ}\!\mathbb{C}$
ESD SENSITIVITY - HBM, C=100pF, R=1.5k		2000	V





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ORDERING INFORMATION

Part Number	Package
GPT15N65GN3P*	TO-3P
GPT15N65GN247*	TO-247
GPT15N65DGN220FP*	TO-220F

^{*}Note: G : Suffix for PB Free Product

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $T_J = 25^{\circ}C$.

			GPT15N65			
Characteristic		Symbol	Min	Тур	Max	Units
Drain-Source Breakdown Voltage		V	650			V
$(V_{GS} = 0 \text{ V}, I_D = 250 \ \mu \text{ A})$		$V_{(BR)DSS}$	650			V
Drain-Source Leakage Current		la sa			1	uA
$(V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V})$		I _{DSS}			!	uA
Gate-Source Leakage Current-Forward		I _{GSSF}			100	nA
$(V_{gsf} = 30 \text{ V}, V_{DS} = 0 \text{ V})$		IGSSF			100	IIA
Gate-Source Leakage Current-Reverse		I _{GSSR}			100	nA
$(V_{gsr} = 30 \text{ V}, V_{DS} = 0 \text{ V})$		IGSSR			100	IIA
Gate Threshold Voltage	9		3		5	V
$(V_{DS} = V_{GS}, I_{D} = 250 \ \mu A)$			3		3	
Static Drain-Source On-Resistance (V _{GS} = 10 V, I _D = 7.5A) *		R _{DS(on)}			0.44	
Forward Transconductance (V _{DS} = 50 V, I _D = 7.5A) *		g FS		16		S
Input Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}.$	C_{iss}		3349		pF
Output Capacitance	$(v_{DS} = 25 \text{ v}, v_{GS} = 0 \text{ v},$ f = 1.0 MHz)	C_{oss}		299.5		pF
Reverse Transfer Capacitance	1 = 1.0 Wil 12)	C_{rss}		11		pF
Turn-On Delay Time		t _{d(on)}		42.13		ns
Rise Time	$(V_{DD} = 325 \text{ V}, I_D = 15 \text{ A},$	t _r		94.93		ns
Turn-Off Delay Time	$R_G = 25$)*	$t_{d(off)}$		69.3		ns
Fall Time		t _f		56.5		ns
Total Gate Charge	()/ 500 \/ 1 45 A	Q_g		64.5		nC
Gate-Source Charge	$(V_{DS} = 520 \text{ V}, I_D = 15 \text{ A},$	Q_{gs}		19.1		nC
Gate-Drain Charge	$V_{GS} = 10 \text{ V})^*$	Q_gd		26.1		nC
	SOURCE-DRAIN DIODE CHA	ARACTERISTICS	•	•		
Forward On-Voltage(1)	() 45.4	V _{SD}			1.5	V
Forward Turn-On Time	(I _S = 15 A,	t _{on}		**		ns
Reverse Recovery Time	$d_{IS}/d_t = 100A/\mu s)$	t _{rr}		556		ns

^{*} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%

^{**} Negligible, Dominated by circuit inductance



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TYPICAL ELECTRICAL CHARACTERISTICS

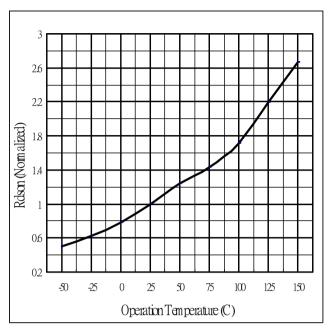


Fig 1. On-Resistance Variation with vs. Temperature

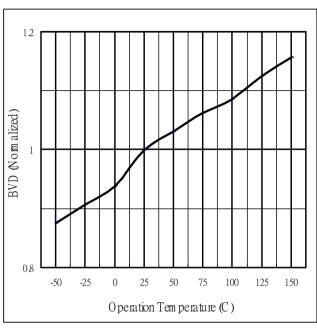


Fig.2 Breakdown Voltage Variation vs. Temperature

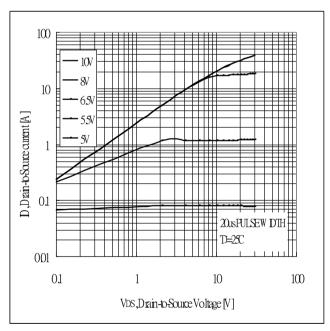


Fig 3. Typical Output Characteristics

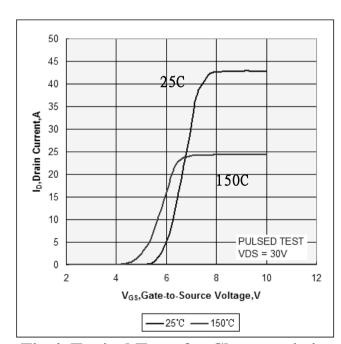


Fig 4. Typical Transfer Characteristics





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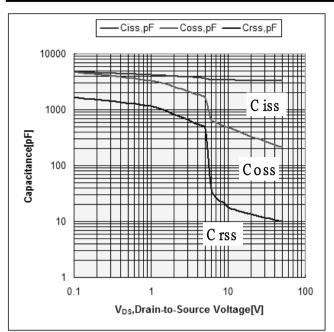


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

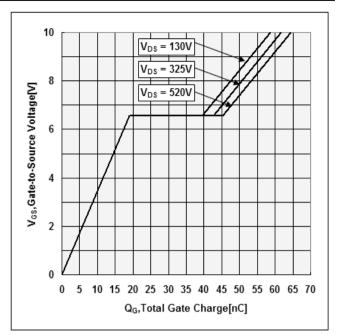


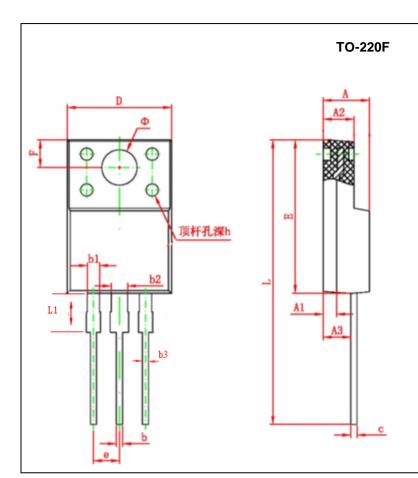
Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage





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PACKAGE DIMENSION

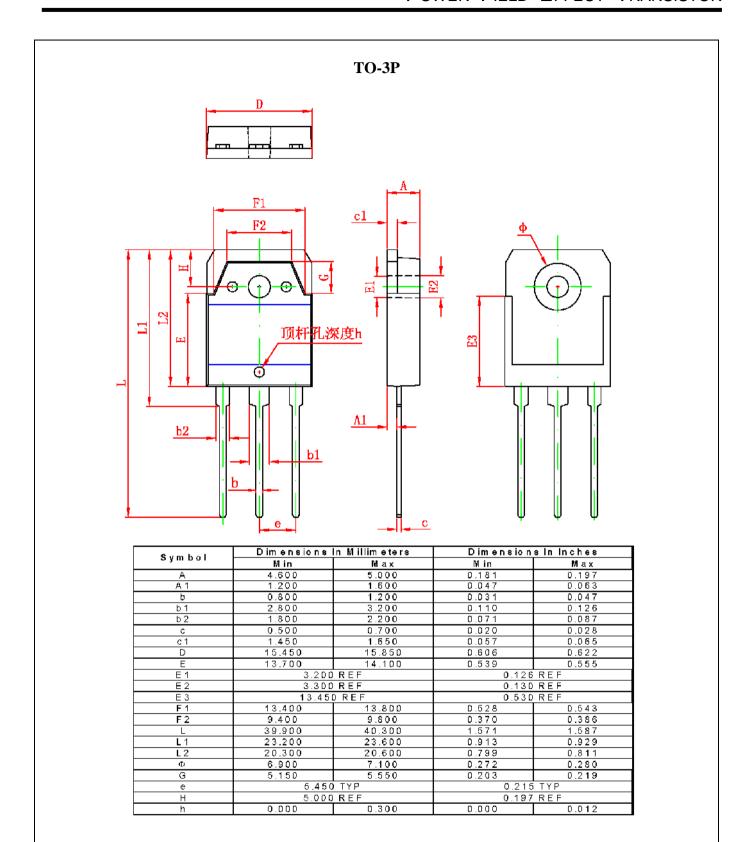


g11	Dimensions In Millimeters			
Symbol	Min.	Max		
Α	3.80	4.70		
A1	1.3 REF.			
A2	2.20	3.20		
А3	2.10	3.20		
Ъ	0.30	0.95		
b1	1.00	1.75		
b2	1.00	1.75		
b3	0.50	0.80		
С	0.30	0.90		
D	9.90	10.40		
E	14.60	16.20		
е	2.54 TYP.			
F	3.00 REF.			
θ	3.50 REF.			
h	0.00	0.30		
L	28.00	30.00		
L1	3.20	3 . 55		





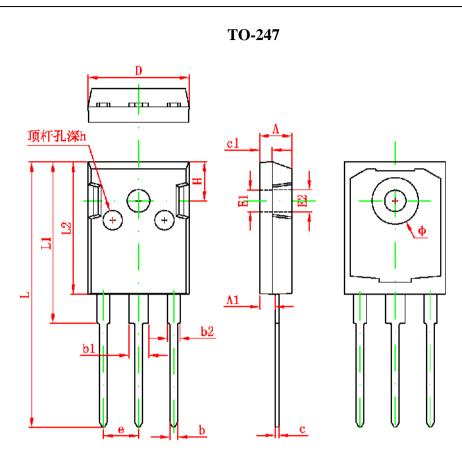
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Symbol	Dimensions In Millimeters		Dimensions In Inches		
Syllibol	Min	Max	Min	Max	
Α	4.850	5.150	0.191	0.200	
A1	2.200	2.600	0.087	0.102	
b	1.000	1.400	0.039	0.055	
b1	2.800	3.200	0.110	0.126	
b2	1.800	2.200	0.071	0.087	
С	0.500	0.700	0.020	0.028	
c1	1.900	2.100	0.075	0.083	
D	15.450	15.750	0.608	0.620	
E1	3.500 REF		0.138 REF		
E2	3.600 REF		0.142 REF		
L	40.900	41.300	1.610	1.626	
L1	24.800	25.100	0.976	0.988	
L2	20.300	20.600	0.799	0.811	
Ф	7.100	7.300	0.280	0.287	
е	5.450 TYP		0.215 TYP		
Н	5.980 REF		0.235 REF		
h	0.000	0.300	0.000	0.012	





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IMPORTANT NOTICE

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